

Electronic Information Disclosure Statement

METHOD FOR PREPARING SUBMICRON PARTICLE SUSPENSIONS



Application:



10/021692

Confirmation: 9772

Applicant(s): James Kipp

Docket

Number:

IFT-5657A-2

Group Art

Unit:

1615

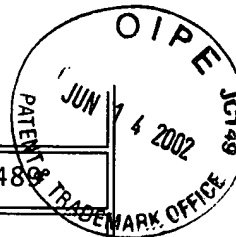
Examiner:

search string: (5560933 or 5552160 or 5543133 or 5534270 or 5518738 or 5510118 or 5494683 or 5470583 or 5447710 or 5429824 or 5399363 or 5389263 or 5352459 or 5346702 or 5340564 or 5336507 or 5326552 or 5302401 or 5298262 or 5250236 or 5246707 or 5188837 or 5152923 or 5145684 or 5133908 or 5100591 or 5091188 or 5091187 or 5078994 or 5023271 or 4973465 or 4798846 or 4725442 or 4622219 or 4540602 or 4452817 or 4073943 or 4056635).pn.

US Patent Documents

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init	Citation No.	Patent Number	Date	Bar Code	Patentee	Class	Subclass
	P01	5560933	1996-10-01		Soon-Shiong et al.	424	489
	P02	5552160	1996-09-03		Liversidge et al.	424	489
	P03	5543133	1996-08-06		Swanson et al.	424	9.45
	P04	5534270	1996-07-09		De Castro	424	490
	P05		1996-05-21		Eickhoff et al.	424	493



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50		5518738					
	P06	5510118	1996-04-23		Bosch et al.	424	489
	P07	5494683	1996-02-27		Liversidge et al.	424	490
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	P09	5447710	1995-09-05		Na et al.	424	489
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	P14	5346702	1994-09-13		Na et al.	424	490
	P15	5340564	1994-08-23		Illig et al.	424	9
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	P17	5326552	1994-07-05		Na et al.	424	4
	P18	5302401	1994-04-12		Liversidge et al.	424	501
	P19	5298262	1994-03-29		Na et al.	424	489
	P20	5250236	1993-10-05		Gasco	264	4.4
	P21	5246707	1993-09-21		Haynes	424	450
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	P24	5145684	1992-09-08		Liversidge et al.	424	489
	P25	5133908	1992-07-28		Stainmesse et al.	264	4.1
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	P29	5078994	1992-01-07		Nair et al.	424	501
	P30	5023271	1991-06-11		Vigne et al.	514	458
	P31	4973465	1990-11-27		Baurain et al.	242	406

88	P32	4798846	1989-01-17		Glen et al.	514	713
	P33	4725442	1988-02-16		Haynes	424	490
	P34	4622219	1986-11-11		Haynes	424	38
	P35	4540602	1985-09-10		Motoyama et al.	427	213.31
	P36	4452817	1984-06-05		Glen et al.	424	346
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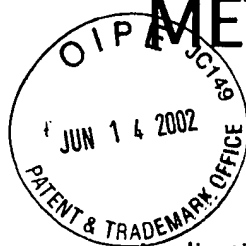


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Examiner Name	Date
<i>Simon Ch</i>	3/17/03

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init	Citation No.	Patent Number	Date	Bar Code	Patentee	Class	Subclass
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1	P02	6299906	2001-10-09		Bausch et al.	424	489
	P03	6294204	2001-09-25		Rossling et al.	424	497
	P04	6270806	2001-08-07		Liversidge et al.	424	497

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P06	6267989	2001-07-31	LIVERSIDGE	Liversidge	424	489
P07	6264922	2001-07-24	WOOD ET AL.	Wood et al.	424	45
P08	6248363	2001-06-19	PATEL ET AL.	Patel et al.	424	497
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P13	6228399	2001-05-08	PARIKH ET AL.	Parikh et al.	424	489
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P25	6090925	2000-07-18	WOISZWILLO ET AL.	Woiszwillo et al.	530	410
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P27	6068858	2000-05-30	LIVERSIDGE ET AL.	Liversidge et al.	424	489
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			LIVERSIDGE ET AL.	Liversidge et		



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P48	5573783	1996-11-12		Desieno et al.	424	490
P49	5569448	1996-10-29		Wong et al.	424	9.45
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Examiner Name	Date
<i>Sinan Or</i>	<i>3/17/03</i>

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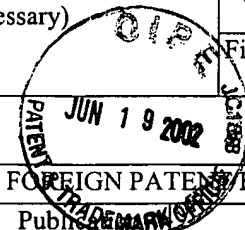


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INFORMATION DISCLOSURE CITATION IN AN APPLICATION (use several sheets if necessary) PTO Form 1449	Atty Docket No. IFT-5657A-2	Application No. 10/021,692
	Applicant James E. Kipp et al.	
	Filing Date 12 December 2001	Group 1615



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Examiner's Initials		Document Number	Publication Date	Country	Class	Subclass	Translation	
							Yes	No
SW		EP 0808154 B1	20 Dec 2000	EP	A61K	9/107	X	
		EP 0804162 B1	5 Sept 2001	EP	A61K	9/14	X	
		EP 0754034 B1	11 July 2001	EP	A61K	9/51	X	
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		WO 99/03450 A1	29 Jan 1999	PCT	A61K	9/16		X
		WO 99/02665 A1	21 Jan 1999	PCT	C12N	9/99	X	

Examiner: <i>Simon</i>	Date Considered: <i>3/17/03</i>
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						Yes	No
SO	WO 99/00113 A1	7 Jan 1999	PCT	A61K	9/22	X	
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	WO 98/07414 A1	26 Feb 1998	PCT	A61K	9/51	X	
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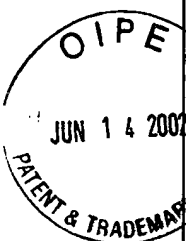
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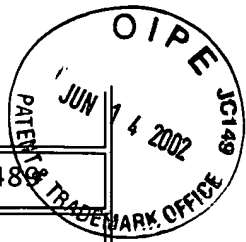
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P09	5447710	1995-09-05		Na et al.	424	489
P10	5429824	1995-07-04		June	424	489
P11	5399363	1995-03-21		Liversidge et al.	424	489
P12	5389263	1995-02-14		Gallagher et al.	210	729
P13	5352459	1994-10-04		Hollister et al.	424	489
P14	5346702	1994-09-13		Na et al.	424	490
P15	5340564	1994-08-23		Illig et al.	424	9
P16	5336507	1994-08-09		Na et al.	424	489
P17	5326552	1994-07-05		Na et al.	424	4
P18	5302401	1994-04-12		Liversidge et al.	424	501
P19	5298262	1994-03-29		Na et al.	424	489
P20	5250236	1993-10-05		Gasco	264	4.4
P21	5246707	1993-09-21		Haynes	424	450
P22	5188837	1993-02-23		Domb	424	450
P23	5152923	1992-10-06		Weder et al.	252	312
P24	5145684	1992-09-08		Liversidge et al.	424	489
P25	5133908	1992-07-28		Stainmesse et al.	264	4.1
P26	5100591	1992-03-31		Leclef et al.	264	4.6
P27	5091188	1992-02-25		Haynes	424	450
P28	5091187	1992-02-25		Haynes	424	450
P29	5078994	1992-01-07		Nair et al.	424	501
P30	5023271	1991-06-11		Vigne et al.	514	458
P31	4973465	1990-11-27		Baurain et al.	242	406

88	P32	4798846	1989-01-17		Glen et al.	514	713
	P33	4725442	1988-02-16		Haynes	424	490
	P34	4622219	1986-11-11		Haynes	424	38
	P35	4540602	1985-09-10		Motoyama et al.	427	213.31
	P36	4452817	1984-06-05		Glen et al.	424	346
	P37	4073943	1978-02-14		Wretlind et al.	424	358
	P38	4056635	1977-11-01		Glen et al.	424	346



Signature

Examiner Name	Date
<i>Simon Chen</i>	3/17/03

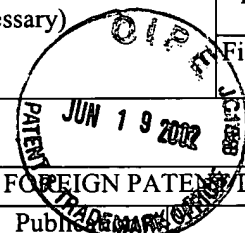
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	Applicant James E. Kipp et al.	
	Filing Date 12 December 2001	Group 1615



FOREIGN PATENT DOCUMENTS							
Examiner's Initials	Document Number	Publication Date	Country	Class	Subclass	Translation	
						Yes	No
SW.	EP 0808154 B1	20 Dec 2000	EP	A61K	9/107	X	
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↓	B. Sjostrom et al., A Method For The Preparation Of Submicron Particles Of Sparingly Water-Soluble Drugs By Precipitation In Oil-In-Water Emulsions. II: Influence Of The Emulsifier, The Solvent And The Drug Substance, J. Pharm. Sci., 82(6), (1992) pp 584-589.

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